

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/706,498	<b>Applicant(s)/Patent under Reexamination</b> ALLEN ET AL.
	<b>Examiner</b> Anthony Weier	<b>Art Unit</b> 1761

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
426	655, 429		
	430, 495	3/29/2006	AW